

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/658,798	BOHLMANN ET AL.	
Examiner		Art Unit		Page 1 of 1
Todd Ingberg		2193		

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,810,429	10-2004	Walsh et al.	709/246
*	B	US-6,397,232	05-2002	Cheng-Hung et al.	715/523
*	C	US-7,133,862	11-2006	Hubert et al.	707/3
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages
	U	XQL: A Query Language for XML Data, W3C.ORG, Hiroshi Ishikawa et al, 1998, 5 pages
	V	A Conversion Tool from DTD to XML Schema, W3.ORG, January 11, 2001, 4 pages
	W	Document Definition Markup Language (DDML) Specification V 1.0, W3.ORG, 1/19/1999, 44 pages
	X	XSLT Working with XML and HTML, Khun Yee Fung, December 28, 2000. Chapters 1,2,3,46,7,12 and 13

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.